

Notice of References Cited		Application/Control No. 10/733,264	Applicant(s)/Patent Under Reexamination HOSHUYAMA, HIDEO	
		Examiner TSUNG-YIN TSAI	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,677,576 A	06-1987	Berlin et al.	345/420
*	B	US-5,710,877 A	01-1998	Marimont et al.	345/427
*	C	US-5,768,438 A	06-1998	Etoh, Minoru	382/251
*	D	US-5,901,252 A	05-1999	Kawakami et al.	382/276
*	E	US-5,909,242 A	06-1999	Kobayashi et al.	348/208.3
*	F	US-6,005,984 A	12-1999	Kawakami et al.	382/276
*	G	US-2001/0003557 A1	06-2001	Hirai et al.	396/225
*	H	US-6,333,792 B1	12-2001	Kimura, Takeo	358/1.2
*	I	US-2002/0051569 A1	05-2002	Kita, Kouji	382/167
*	J	US-6,388,709 B1	05-2002	Kobayashi et al.	348/362
*	K	US-6,487,309 B1	11-2002	Chen, Zhe-Hong	382/162
*	L	US-6,927,874 B1	08-2005	Enokida et al.	358/1.18
*	M	US-2005/0244053 A1	11-2005	Hayaishi, Ikuo	382/164

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 632649 A1	01-1995	European Patent	KOBAYASHI et al.	H04N 05/232
*	O	JP 11164190 A	06-1999	Japan	MAEHARA, NORIAKI	H04N 05/235
*	P	JP 2003333631 A	11-2003	Japan	KOMATSU, SOUMA	H04N 17/04
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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